Hex Buffers/Logic-Level Down Converters

High-Performance Silicon-Gate CMOS

The MC54/74HC4049 consists of six inverting buffers, and the MC54/74HC4050 consists of six noninverting buffers. They are identical in pinout to the MC14049UB and MC14050B metal–gate CMOS buffers. The device inputs are compatible with standard CMOS outputs; with pullup resistors, they are compatible with LSTTL outputs.

The input protection circuitry on these devices has been modified by eliminating the V_{CC} diodes to allow the use of input voltages up to 15 volts. Thus, the devices may be used as logic–level translators that convert from a high voltage to a low voltage while operating at the low–voltage power supply. They allow MC14000–series CMOS operating up to 15 volts to be interfaced with High–Speed CMOS at 2 to 6 volts. The protection diodes to GND are Zener diodes, which protect the inputs from both positive and negative voltage transients.

- Output Drive Capability: 10 LSTTL Loads
- · Outputs Directly Interface to CMOS, NMOS, and TTL
- Operating Voltage Range: 2 to 6 V

HC4049

- Low Input Current: 5 μA
- High Noise Immunity Characteristic of CMOS Devices
- In Compliance with the Requirements Defined by JEDEC Standard No. 7A
- Chip Complexity: 36 FETs or 9 Equivalent Gates (4049)
 24 FETs or 6 Equivalent Gates (4050)

LOGIC DIAGRAMS

HC4050

PIN 8 = GND

PINS 13, 16 = NO CONNECTION

MC54/74HC4049 MC54/74HC4050



J SUFFIX

CERAMIC PACKAGE CASE 620–10



N SUFFIX

PLASTIC PACKAGE CASE 648-08



D SUFFIX

SOIC PACKAGE CASE 751B-05

ORDERING INFORMATION

MC54HCXXXXJ Ceramic MC74HCXXXXN Plastic MC74HCXXXXD SOIC

PIN ASSIGNMENT

Vcc [1 ●	16	пс
Y0 [2	15	Y5
A0 [3	14	A5
Y1 [4	13	NC
A1 [5	12	Y4
Y2 [6	11	A4
A2 [7	10	Y3
GND [8	9	A3
			•

NC = NO CONNECTION

FUNCTION TABLE

Α	Y Outputs			
Input	HC4049 HC406			
L	Н	L		
Н	L	Н		



MAXIMUM RATINGS*

Symbol	Parameter	Value	Unit
VCC	DC Supply Voltage (Referenced to GND)	- 0.5 to + 7.0	V
V _{in}	DC Input Voltage (Referenced to GND)	- 1.5 to + 18	V
V _{out}	DC Output Voltage (Referenced to GND)	-0.5 to V _{CC} + 0.5	V
l _{in}	DC Input Current, per Pin	± 20	mA
l _{out}	DC Output Current, per Pin	± 25	mA
ICC	DC Supply Current, V _{CC} and GND Pins	± 50	mA
PD	Power Dissipation in Still Air, Plastic or Ceramic DIP† SOIC Package†	750 500	mW
T _{stg}	Storage Temperature	- 65 to + 150	°C
TL	Lead Temperature, 1 mm from Case for 10 Seconds (Plastic DIP or SOIC Package) (Ceramic DIP)	260 300	°C

This device contains circuitry to protect the inputs against damage due to high static voltages or electric fields referenced to the GND pin, only. Extra precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high–impedance circuit. For proper operation, the ranges GND \leq V $_{in}$ \leq 15 V and GND \leq V $_{out}$ \leq V $_{CC}$ are recommended.

Ceramic DIP: - 10 mW/°C from 100° to 125°C

SOIC Package: - 7 mW/°C from 65° to 125°C

For high frequency or heavy load considerations, see Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter			Max	Unit
VCC	DC Supply Voltage (Referenced to GND)	2.0	6.0	V
V _{in}	DC Input Voltage (Referenced to GND)			V _{CC} to 15	V
V _{out}	DC Output Voltage (Referenced to GND)		0	Vcc	V
TA	Operating Temperature, All Package Types		- 55	+ 125	°C
t _r , t _f	Input Rise and Fall Time (Figure 1)	V _{CC} = 2.0 V V _{CC} = 4.5 V V _{CC} = 6.0 V	0 0 0	1000 500 400	ns

DC ELECTRICAL CHARACTERISTICS (Voltages Referenced to GND)

				Gu	aranteed Li	mit	
Symbol	Parameter	Test Conditions	V _{CC}	– 55 to 25°C	≤ 85°C	≤ 125°C	Unit
VIH	Minimum High-Level Input Voltage	$V_{\text{Out}} = V_{\text{CC}} - 0.1 \text{ V}$ $ I_{\text{Out}} \le 20 \mu\text{A}$	2.0 4.5 6.0	1.5 3.15 4.2	1.5 3.15 4.2	1.5 3.15 4.2	V
VIL	Maximum Low–Level Input Voltage	$V_{Out} = 0.1 \text{ V or } V_{CC} - 0.1 \text{ V}$ $ I_{Out} \le 20 \mu\text{A}$	2.0 4.5 6.0	0.3 0.9 1.2	0.3 0.9 1.2	0.3 0.9 1.2	V
VOH	Minimum High-Level Output Voltage	$V_{in} = V_{IH}$ $ I_{out} \le 20 \mu\text{A}$	2.0 4.5 6.0	1.9 4.4 5.9	1.9 4.4 5.9	1.9 4.4 5.9	V
		$V_{\text{in}} = V_{\text{IH}} \text{ or } V_{\text{IL}} I_{\text{Out}} \le 4.0 \text{ mA} $ $ I_{\text{Out}} \le 5.2 \text{ mA}$	4.5 6.0	3.98 5.48	3.84 5.34	3.70 5.20	
VOL	Maximum Low–Level Output Voltage	$V_{in} = V_{IH} \text{ or } V_{IL}$ $ I_{out} \le 20 \mu\text{A}$	2.0 4.5 6.0	0.1 0.1 0.1	0.1 0.1 0.1	0.1 0.1 0.1	V
		$V_{\text{in}} = V_{\text{IH}} \text{ or } V_{\text{IL}} I_{\text{Out}} \le 4.0 \text{ mA} $ $ I_{\text{Out}} \le 5.2 \text{ mA}$	4.5 6.0	0.26 0.26	0.33 0.33	0.40 0.40	
l _{in}	Maximum Input Leakage Current	V _{in} = V _{CC} or GND V _{in} = 15 V	6.0 6.0	± 0.1 0.5	± 1.0 5.0	± 1.0 5.0	μА
lcc	Maximum Quiescent Supply Current (per Package)	V _{in} = 15 V or GND I _{out} = 0 μA	6.0	2	20	40	μА

NOTE: Information on typical parametric values can be found in Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

Unused inputs must always be tied to an appropriate logic voltage level (e.g., either GND or VCC).

^{*} Maximum Ratings are those values beyond which damage to the device may occur. Functional operation should be restricted to the Recommended Operating Conditions.

[†]Derating — Plastic DIP: – 10 mW/°C from 65° to 125°C

AC ELECTRICAL CHARACTERISTICS ($C_L = 50$ pF, Input $t_f = t_f = 6$ ns)

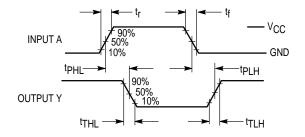
			Guaranteed Limit		mit	
Symbol	Parameter	V _{CC}	– 55 to 25°C	≤ 85°C	≤ 125°C	Unit
t _{PLH} , t _{PHL}	Maximum Propagation Delay, Input A to Output Y (Figures 1 and 2)	2.0 4.5 6.0	85 17 14	105 21 18	130 26 22	ns
tTLH, tTHL	Maximum Output Transition Time, Any Output (Figures 1 and 2)	2.0 4.5 6.0	75 15 13	95 19 16	110 22 19	ns
C _{in}	Maximum Input Capacitance		10	10	10	pF

NOTES:

- 1. For propagation delays with loads other than 50 pF, see Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).
- 2. Information on typical parametric values can be found in Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

		Typical @ 25°C, V _{CC} = 5.0 V	
C _{PD}	Power Dissipation Capacitance (Per Buffer)*	27	pF

^{*}Used to determine the no-load dynamic power consumption: P_D = C_{PD} V_{CC}²f + I_{CC} V_{CC}. For load considerations, see Chapter 2 of the Motorola High–Speed CMOS Data Book (DL129/D).



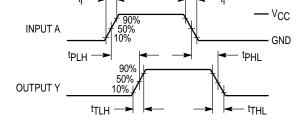
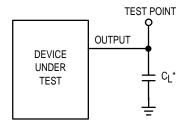


Figure 1a. Switching Waveforms (HC4049)

Figure 1b. Switching Waveforms (HC4050)

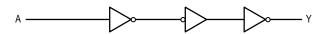


* Includes all probe and jig capacitance

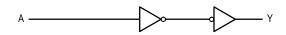
Figure 2. Test Circuit

LOGIC DETAIL

HC4049 (1/6 of the Device)

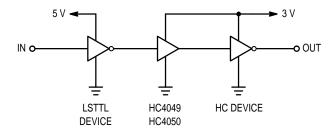


HC4050 (1/6 of the Device)

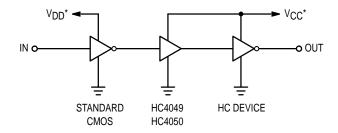


TYPICAL APPLICATIONS

LSTTL to Low-Voltalge HSCMOS



High-Voltage CMOS to HSCMOS



NOTE: To determine the noise immunity for the LSTTL to low-voltage

configuration, use Eq. 1 and Eq. 2: (TTL) V_{OH} – (CMOS) V_{IH} Eq.

(TTL) VOL - (CMOS) VIL

For the supply levels shown:

2.4 - 3 (75%) = 2.4 - 2.25 = 0.15 V

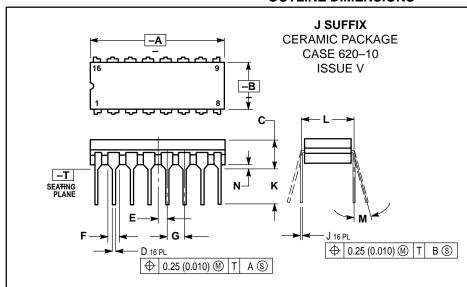
0.4 - 3 (15%) = 0.4 - 0.45 = 0.05 V

Therefore, worst case noise immunity is 50 mV. For supply levels greater than 4.5 volts use the 74HCT04A for direct interface to TTL outputs.

*Table 1. Supply Examples

V_{DD}	VCC
15 V	2 V
12 V	5 V
12 V	3 V

OUTLINE DIMENSIONS



В

D 16 PL

⊕ 0.25 (0.010) M T A M

-A

G

16

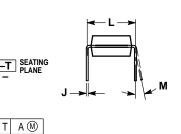
NOTES:

- DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: INCH.
 DIMENSION L TO CENTER OF LEAD WHEN
 FORMED PARALLEL.
- DIM F MAY NARROW TO 0.76 (0.030) WHERE THE LEAD ENTERS THE CERAMIC BODY.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.750	0.785	19.05	19.93
В	0.240	0.295	6.10	7.49
С	_	0.200	_	5.08
D	0.015	0.020	0.39	0.50
Е	0.050) BSC	1.27	BSC
F	0.055	0.065	1.40	1.65
G	0.100 BSC		2.54	BSC
J	0.008	0.015	0.21	0.38
K	0.125	0.170	3.18	4.31
L	0.300) BSC	7.62	BSC
M	0°	15°	0°	15°
N	0.020	0.040	0.51	1.01

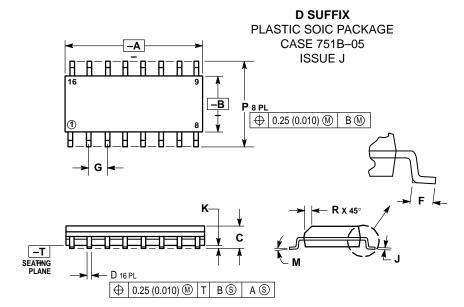
N SUFFIX

PLASTIC PACKAGE CASE 648-08 **ISSUE R**



- DIMENSIONING AND TOLERANCING PER ANSI
- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL. DIMENSION B DOES NOT INCLUDE MOLD FLASH. ROUNDED CORNERS OPTIONAL.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.740	0.770	18.80	19.55
В	0.250	0.270	6.35	6.85
С	0.145	0.175	3.69	4.44
D	0.015	0.021	0.39	0.53
F	0.040	0.070	1.02	1.77
G	0.	100 BSC	2	.54 BSC
Н	0.	050 BSC	1	.27 BSC
J	0.008	0.015	0.21	0.38
K	0.110	0.130	2.80	3.30
L	0.295	0.305	7.50	7.74
M	0°	10°	0°	10°
S	0.020	0.040	0.51	1.01



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- T 14-30M, 1962.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSIONS A AND B DO NOT INCLUDE
 MOLD PROTRUSION.
 MAXIMUM MOLD PROTRUSION 0.15 (0.006)

- MAXIMUM MOLD PROTRUSION 0.15 (0.006)
 PER SIDE.
 DIMENSION D DOES NOT INCLUDE DAMBAR
 PROTRUSION. ALLOWABLE DAMBAR
 PROTRUSION SHALL BE 0.127 (0.005) TOTAL
 IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

	MILLIMETERS		INC	HES
DIM	MIN	MAX	MIN	MAX
Α	9.80	10.00	0.386	0.393
В	3.80	4.00	0.150	0.157
С	1.35	1.75	0.054	0.068
D	0.35	0.49	0.014	0.019
F	0.40	1.25	0.016	0.049
G	1.2	7 BSC	0.050) BSC
J	0.19	0.25	0.008	0.009
K	0.10	0.25	0.004	0.009
M	0°	7°	0°	7°
Р	5.80	6.20	0.229	0.244
R	0.25	0.50	0.010	0.019

MC54/74HC4049 MC54/74HC4050

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